

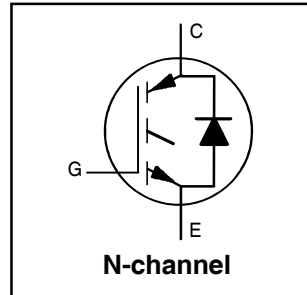
IRGP30B120KD-E

INSULATED GATE BIPOLAR TRANSISTOR WITH ULTRAFAST SOFT RECOVERY DIODE

Motor Control Co-Pack IGBT

Features

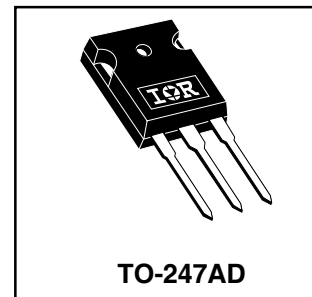
- Low $V_{CE(on)}$ Non Punch Through (NPT) Technology
- Low Diode V_F (1.76V Typical @ 25A & 25°C)
- 10 μ s Short Circuit Capability
- Square RBSOA
- Ultrasoft Diode Recovery Characteristics
- Positive $V_{CE(on)}$ Temperature Coefficient
- Extended Lead TO-247AD Package



$V_{CES} = 1200V$
 $V_{CE(on) \text{ typ.}} = 2.28V$
 $V_{GE} = 15V, I_C = 25A, 25^\circ C$

Benefits

- Benchmark Efficiency for Motor Control Applications
- Rugged Transient Performance
- Low EMI
- Significantly Less Snubber Required
- Excellent Current Sharing in Parallel Operation
- Longer leads for Easier Mounting



Absolute Maximum Ratings

| | Parameter | Max. | Units |
|---------------------------|--|--------------------|-------|
| V_{CES} | Collector-to-Emitter Breakdown Voltage | 1200 | V |
| $I_C @ T_C = 25^\circ C$ | Continuous Collector Current (Fig.1) | 60 | A |
| $I_C @ T_C = 100^\circ C$ | Continuous Collector Current (Fig.1) | 30 | |
| I_{CM} | Pulsed Collector Current (Fig.3, Fig. CT.5) | 120 | |
| I_{LM} | Clamped Inductive Load Current(Fig.4, Fig. CT.2) | 120 | |
| $I_F @ T_C = 100^\circ C$ | Diode Continuous Forward Current | 30 | |
| I_{FM} | Diode Maximum Forward Current | 120 | |
| V_{GE} | Gate-to-Emitter Voltage | ± 20 | V |
| $P_D @ T_C = 25^\circ C$ | Maximum Power Dissipation (Fig.2) | 300 | W |
| $P_D @ T_C = 100^\circ C$ | Maximum Power Dissipation (Fig.2) | 120 | |
| T_J | Operating Junction and | -55 to + 150 | °C |
| T_{STG} | Storage Temperature Range | | |
| | Soldering Temperature, for 10 seconds | | |
| | Mounting Torque, 6-32 or M3 screw. | 10 lbf•in (1.1N•m) | |

Thermal Resistance

| | Parameter | Min. | Typ. | Max. | Units |
|-----------------|---|------|----------|------|--------|
| $R_{\theta JC}$ | Junction-to-Case - IGBT | — | — | 0.42 | °C/W |
| $R_{\theta JC}$ | Junction-to-Case - Diode | — | — | 0.83 | |
| $R_{\theta CS}$ | Case-to-Sink, flat, greased surface | — | 0.24 | — | |
| $R_{\theta JA}$ | Junction-to-Ambient, typical socket mount | — | — | 40 | |
| W_t | Weight | — | 6 (0.21) | — | g (oz) |
| $Z_{\theta JC}$ | Transient Thermal Impedance Junction-to-Case (Fig.24) | | | | |

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Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions | Fig. |
|---|---|------|-------|------|-------|--|------------|
| V _{(BR)CES} | Collector-to-Emitter Breakdown Voltage | 1200 | | | V | V _{GE} = 0V, I _C = 250 μA | |
| ΔV _{(BR)CES} / ΔT _J | Temperature Coeff. of Breakdown Voltage | | +1.2 | | V/°C | V _{GE} = 0V, I _C = 1 mA (25 -125 °C) | |
| V _{CE(on)} | Collector-to-Emitter Saturation Voltage | | 2.28 | 2.48 | V | I _C = 25A, V _{GE} = 15V | 5, 6 |
| | | | 2.46 | 2.66 | | I _C = 30A, V _{GE} = 15V | 7, 9 |
| | | | 3.43 | 4.00 | | I _C = 60A, V _{GE} = 15V | 10 |
| | | | 2.74 | 3.10 | | I _C = 25A, V _{GE} = 15V, T _J = 125°C | 11 |
| | | | 2.98 | 3.35 | | I _C = 30A, V _{GE} = 15V, T _J = 125°C | |
| V _{GE(th)} | Gate Threshold Voltage | 4.0 | 5.0 | 6.0 | V | V _{CE} = V _{GE} , I _C = 250 μA | 9,10,11,12 |
| ΔV _{GE(th)} / ΔT _J | Temperature Coeff. of Threshold Voltage | | - 1.2 | | mV/°C | V _{CE} = V _{GE} , I _C = 1 mA (25 -125 °C) | |
| g _{fe} | Forward Transconductance | 14.8 | 16.9 | 19.0 | S | V _{CE} = 50V, I _C = 25A, PW=80μs | |
| I _{CES} | Zero Gate Voltage Collector Current | | | 250 | μA | V _{GE} = 0V, V _{CE} = 1200V | |
| | | | 325 | 675 | | V _{GE} = 0v, V _{CE} = 1200V, T _J =125°C | |
| | | | | 2000 | | V _{GE} = 0v, V _{CE} = 1200V, T _J =150°C | |
| V _{FM} | Diode Forward Voltage Drop | | 1.76 | 2.06 | V | I _C = 25A | 8 |
| | | | 1.86 | 2.17 | | I _C = 30A | |
| | | | 1.87 | 2.18 | | I _C = 25A, T _J = 125°C | |
| | | | 2.01 | 2.40 | | I _C = 30A, T _J = 125°C | |
| I _{GES} | Gate-to-Emitter Leakage Current | | | ±100 | nA | V _{GE} = ±20V | |

Switching Characteristics @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions | Fig. |
|------------------|--------------------------------------|-------------|------|------|-------|---|------------|
| Q _g | Total Gate charge (turn-on) | | 169 | 254 | nC | I _C = 25A | 23 |
| Q _{ge} | Gate - Emitter Charge (turn-on) | | 19 | 29 | | V _{CC} =600V | CT1 |
| Q _{gc} | Gate - Collector Charge (turn-on) | | 82 | 123 | | V _{GE} = 15V | |
| E _{on} | Turn-On Switching Loss | | 1066 | 1250 | μJ | I _C = 25A, V _{CC} = 600V | CT4 |
| E _{off} | Turn-Off Switching Loss | | 1493 | 1800 | | V _{GE} = 15V, R _g = 5Ω, L=200μH | WF1 |
| E _{tot} | Total Switching Loss | | 2559 | 3050 | | T _J = 25°C, Energy losses include tail and diode reverse recovery | WF2 |
| E _{on} | Turn-on Switching Loss | | 1660 | 1856 | μJ | I _C =25A, V _{CC} =600V | 13, 15 |
| E _{off} | Turn-off Switching Loss | | 2118 | 2580 | | V _{GE} = 15V, R _g = 5Ω, L=200μH | CT4 |
| E _{tot} | Total Switching Loss | | 3778 | 4436 | | T _J = 125°C, Energy losses include tail and diode reverse recovery | WF1 & 2 |
| td(on) | Turn - on delay time | | 50 | 65 | ns | I _C =25A, V _{CC} =600V | 14, 16 |
| tr | Rise time | | 25 | 35 | | V _{GE} = 15V, R _g = 5Ω, L=200μH | CT4 |
| td(off) | Turn - off delay time | | 210 | 230 | | T _J = 125°C, | WF1 |
| tf | Fall time | | 60 | 75 | | | WF2 |
| C _{ies} | Input Capacitance | | 2200 | | pF | V _{GE} = 0V | 22 |
| C _{oes} | Output Capacitance | | 210 | | | V _{CC} = 30V | |
| C _{res} | Reverse Transfer Capacitance | | 85 | | | f = 1.0 MHz | |
| RBSOA | Reverse bias safe operating area | FULL SQUARE | | | | T _J =150°C, I _C = 120A V _{CC} = 1000V, V _P = 1200V R _g = 5Ω, V _{GE} = +15V to 0 V | 4 CT2 |
| SCSOA | Short Circuit Safe Operating Area | 10 | ---- | ---- | μs | T _J = 150°C V _{CC} = 900V, V _P = 1200V R _g = 5Ω, V _{GE} = +15V to 0 V | CT3 WF4 |
| E _{rec} | Reverse recovery energy of the diode | | 1820 | 2400 | μJ | T _J = 125°C | 17,18,19 |
| t _{rr} | Diode Reverse recovery time | | 300 | | ns | V _{CC} = 600V, I _C = 25A | 20, 21 |
| I _{rr} | Peak Reverse Recovery Current | | 34 | 38 | A | V _{GE} = 15V, R _g = 5Ω, L=200μH | CT4, WF3 |
| L _e | Internal Emitter Inductance | | 13 | | nH | Measured 5 mm from the package. | |

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Fig.1 - Maximum DC Collector Current vs. Case Temperature

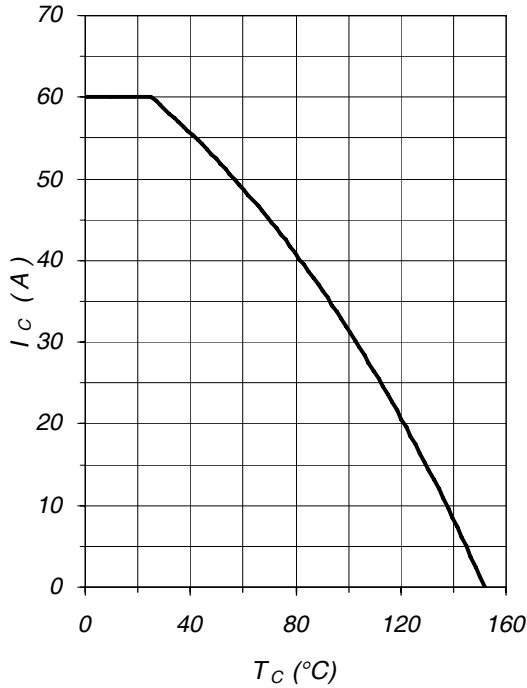


Fig.2 - Power Dissipation vs. Case Temperature

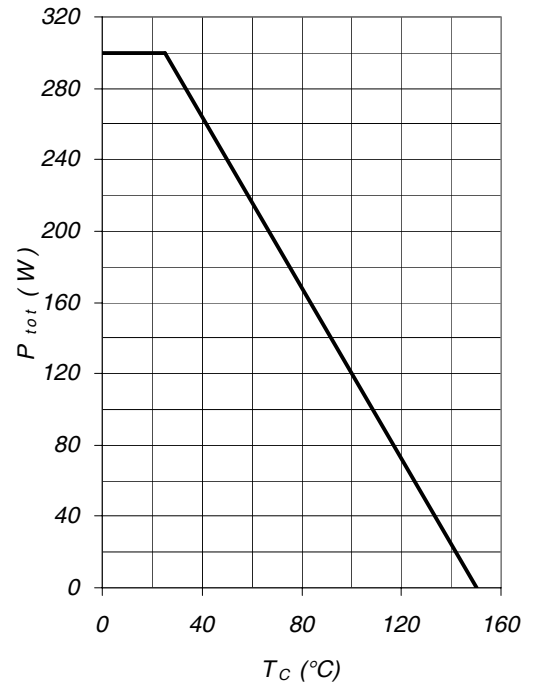


Fig.3 - Forward SOA
 $T_C=25^{\circ}C$; $T_j \leq 150^{\circ}C$

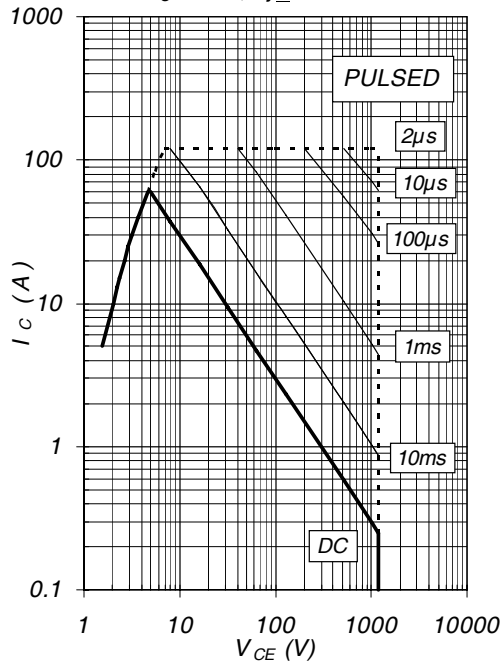


Fig.4 - Reverse Bias SOA
 $T_j = 150^{\circ}C$, $V_{GE} = 15V$

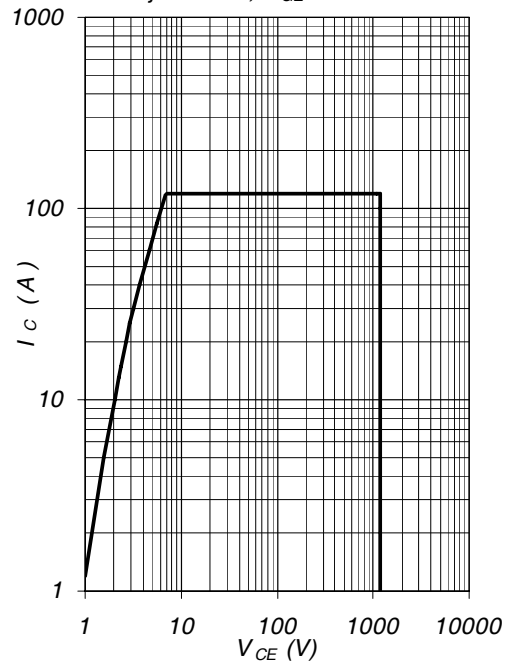


Fig.5 - Typical IGBT Output Characteristics
 $T_j = -40^\circ\text{C}; t_p = 300\mu\text{s}$

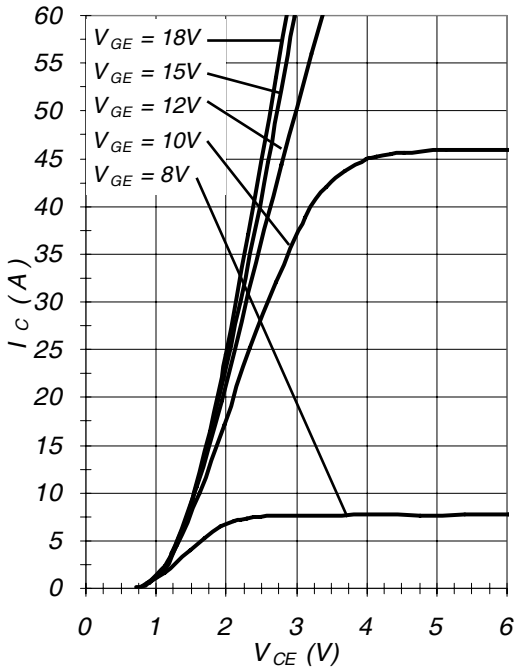


Fig.6 - Typical IGBT Output Characteristics
 $T_j = 25^\circ\text{C}; t_p = 300\mu\text{s}$

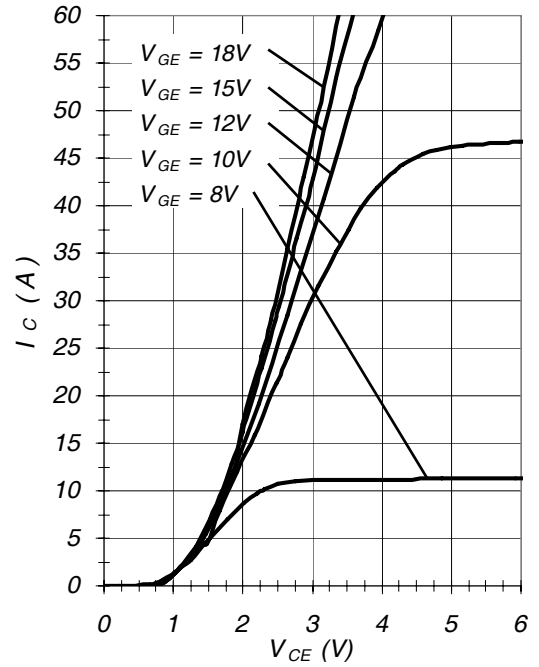


Fig.7 - Typical IGBT Output Characteristics
 $T_j = 125^\circ\text{C}; t_p = 300\mu\text{s}$

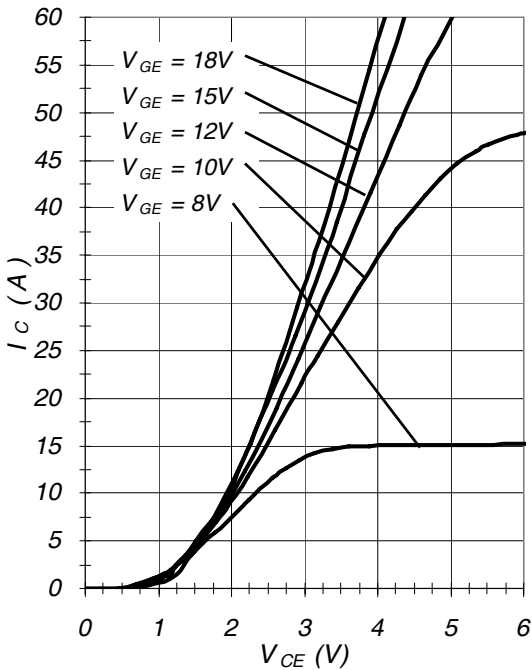
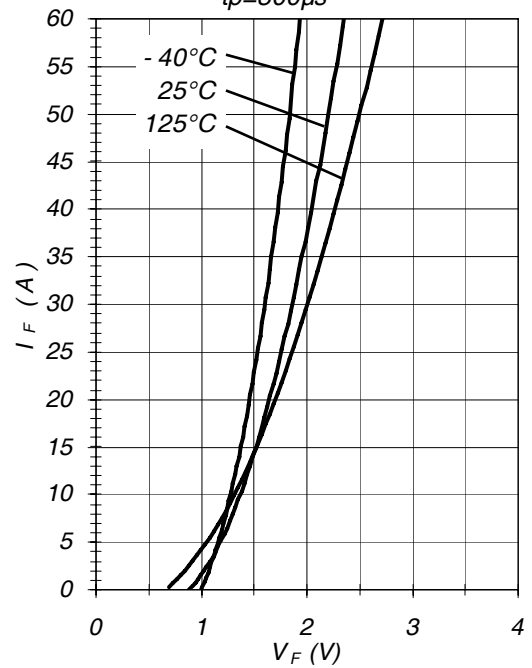


Fig.8 - Typical Diode Forward Characteristic
 $t_p = 300\mu\text{s}$



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Fig.9 - Typical V_{CE} vs V_{GE}
 $T_j = -40^\circ\text{C}$

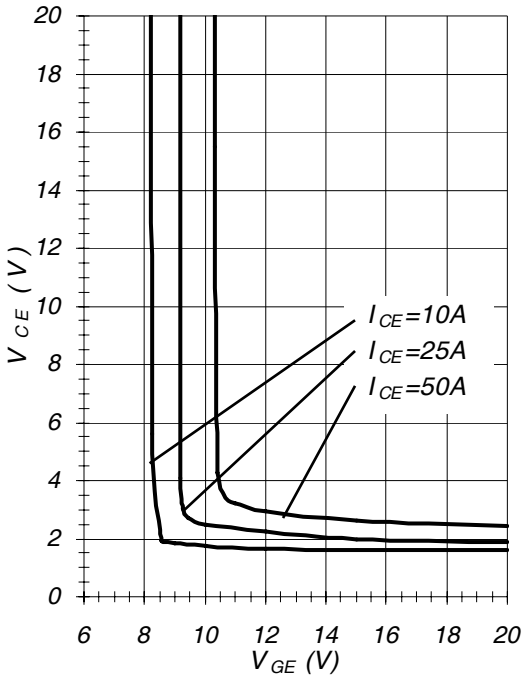


Fig.10 - Typical V_{CE} vs V_{GE}
 $T_j = 25^\circ\text{C}$

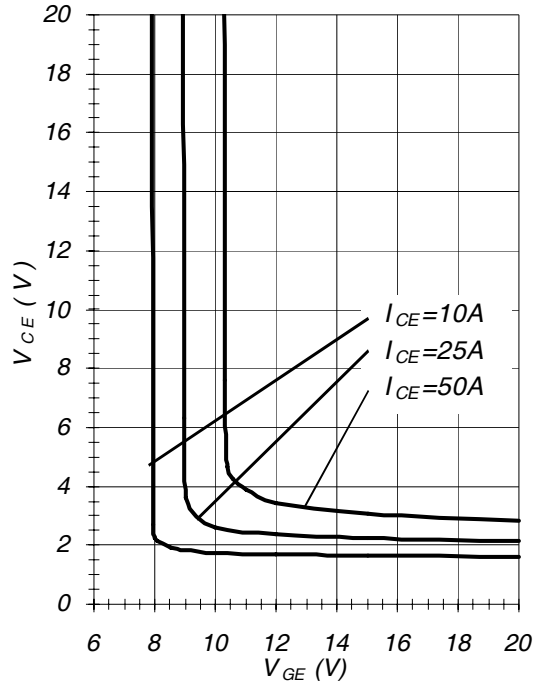


Fig.11 - Typical V_{CE} vs V_{GE}
 $T_j = 125^\circ\text{C}$

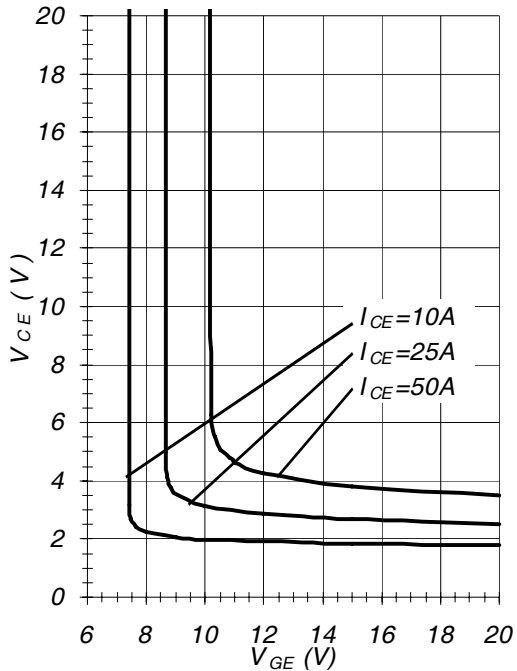
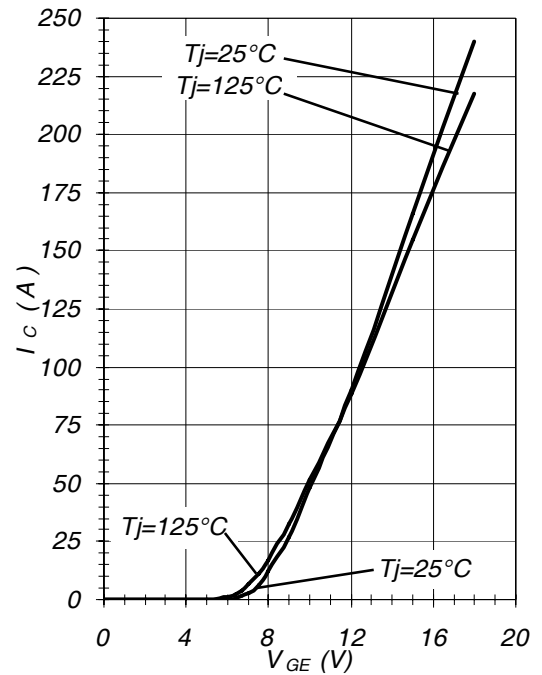


Fig.12 - Typ. Transfer Characteristics
 $V_{CE} = 20\text{V}$; $t_p = 20\mu\text{s}$



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Fig.13 - Typical Energy Loss vs I_C
 $T_j=125^\circ\text{C}$; $L=200\mu\text{H}$; $V_{CE}=600\text{V}$;
 $R_g=22\ \Omega$; $V_{GE}=15\text{V}$

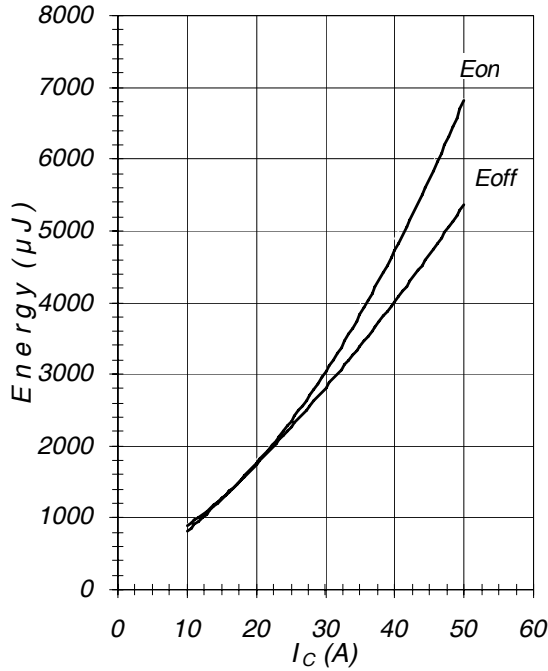


Fig.14 - Typical Switching Time vs I_C
 $T_j=125^\circ\text{C}$; $L=200\mu\text{H}$; $V_{CE}=600\text{V}$;
 $R_g=22\ \Omega$; $V_{GE}=15\text{V}$

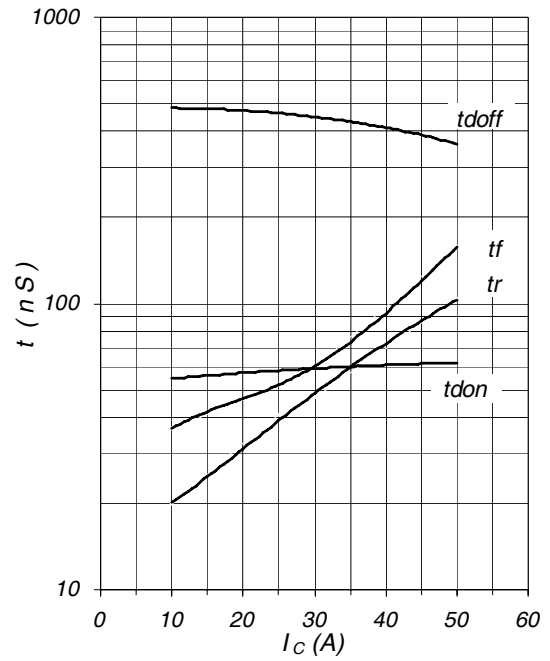


Fig.15 - Typical Energy Loss vs R_g
 $T_j=125^\circ\text{C}$; $L=200\mu\text{H}$; $V_{CE}=600\text{V}$;
 $I_{CE}=25\text{A}$; $V_{GE}=15\text{V}$

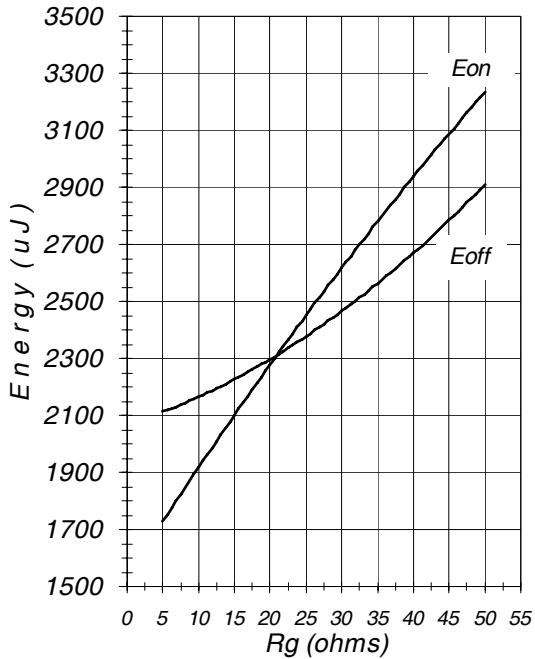
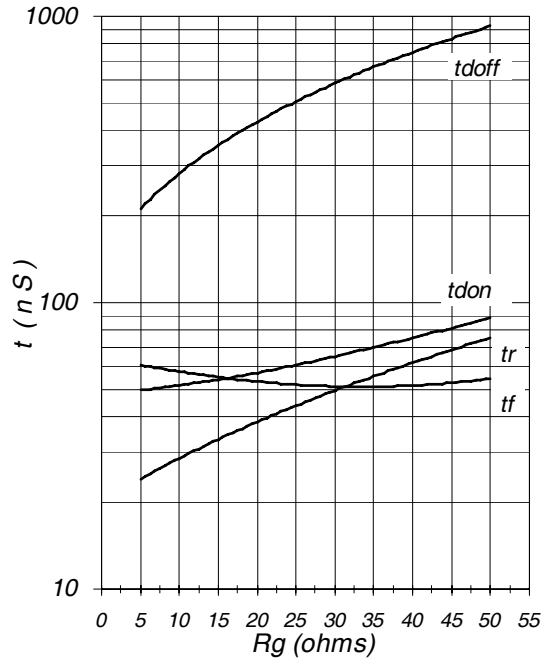


Fig.16 - Typical Switching Time vs R_g
 $T_j=125^\circ\text{C}$; $L=200\mu\text{H}$; $V_{CE}=600\text{V}$;
 $I_{CE}=25\text{A}$; $V_{GE}=15\text{V}$



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Fig.17 - Typical Diode I_{RR} vs I_F
 $T_j=125^\circ\text{C}$

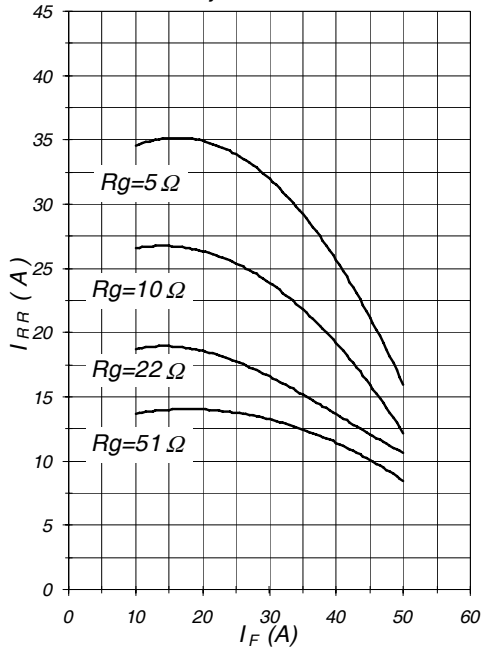


Fig.18 - Typical Diode I_{RR} vs R_g
 $T_j=125^\circ\text{C}; I_F=25\text{A}$

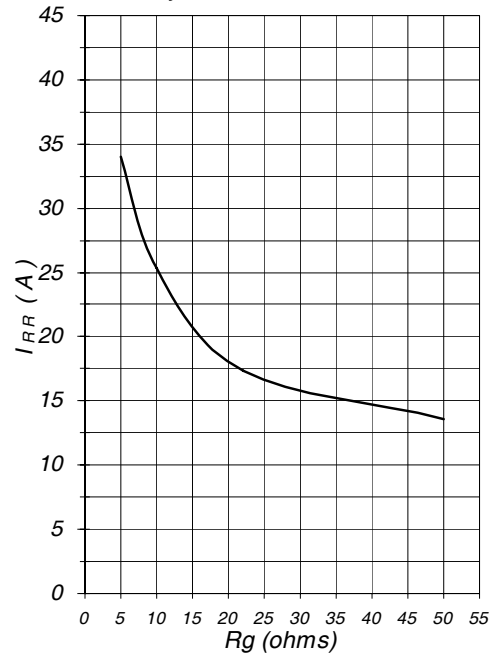


Fig.19 - Typical Diode I_{RR} vs di_F/dt
 $V_{CC}=600\text{V}; V_{GE}=15\text{V}$
 $I_F=25\text{A}; T_j=125^\circ\text{C}$

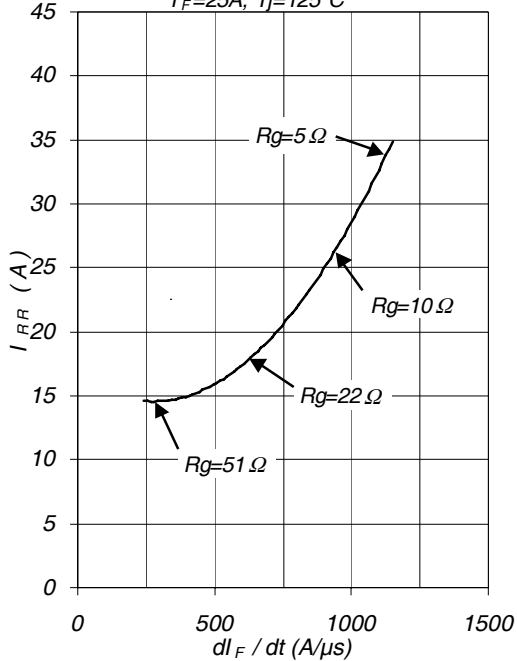


Fig.20 - Typical Diode Q_{RR}
 $V_{CC}=600\text{V}; V_{GE}=15\text{V}; T_j=125^\circ\text{C}$

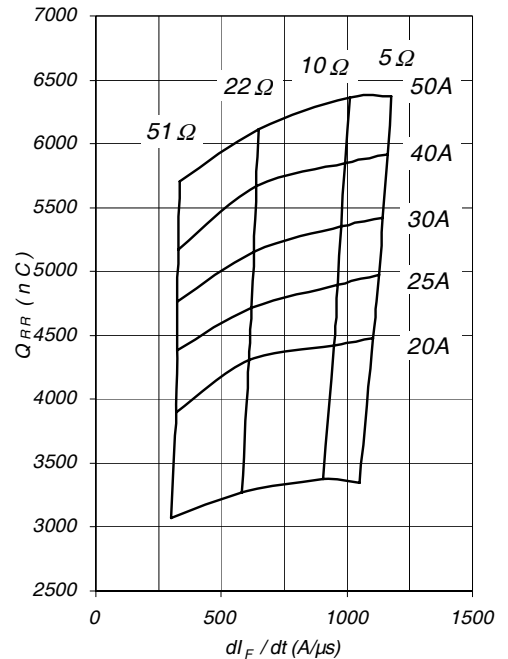


Fig.21 - Typ. Diode E_{rec} vs. I_F
 $T_j=125^\circ\text{C}$

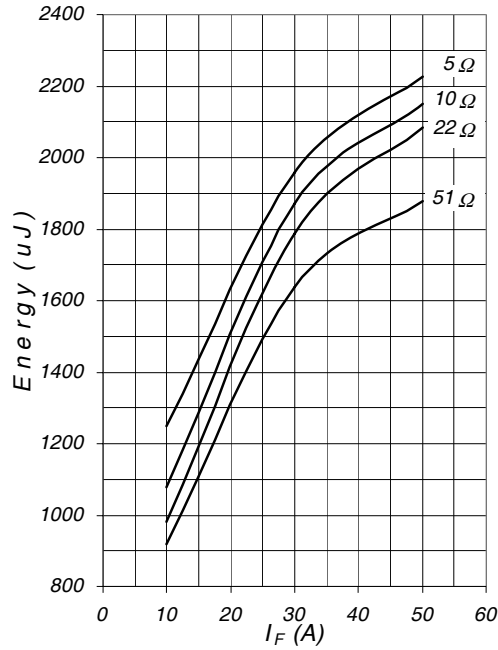


Fig.22 - Typical Capacitance vs V_{CE}
 $V_{GE}=0\text{V}$; $f=1\text{MHz}$

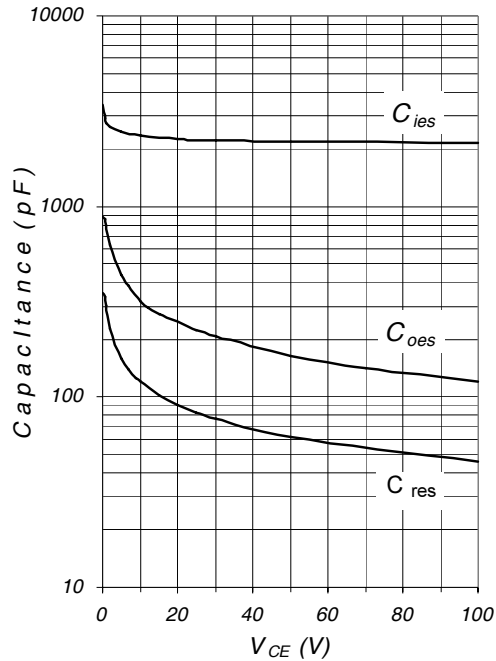


Fig.23 - Typ. Gate Charge vs. V_{GE}
 $I_C=25\text{A}$; $L=600\ \mu\text{H}$

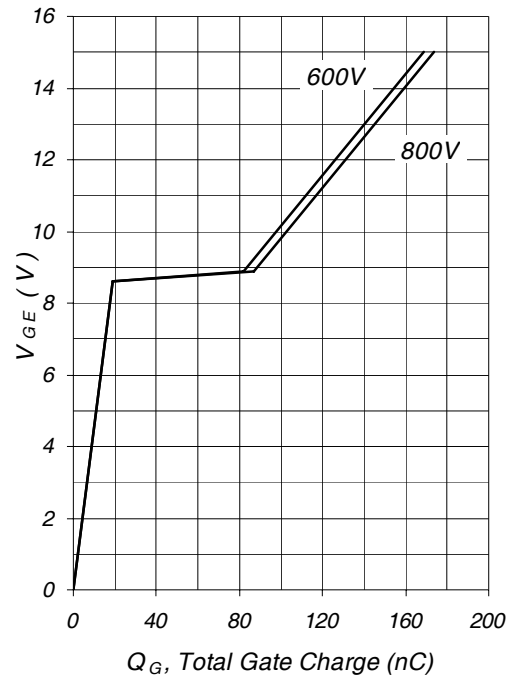
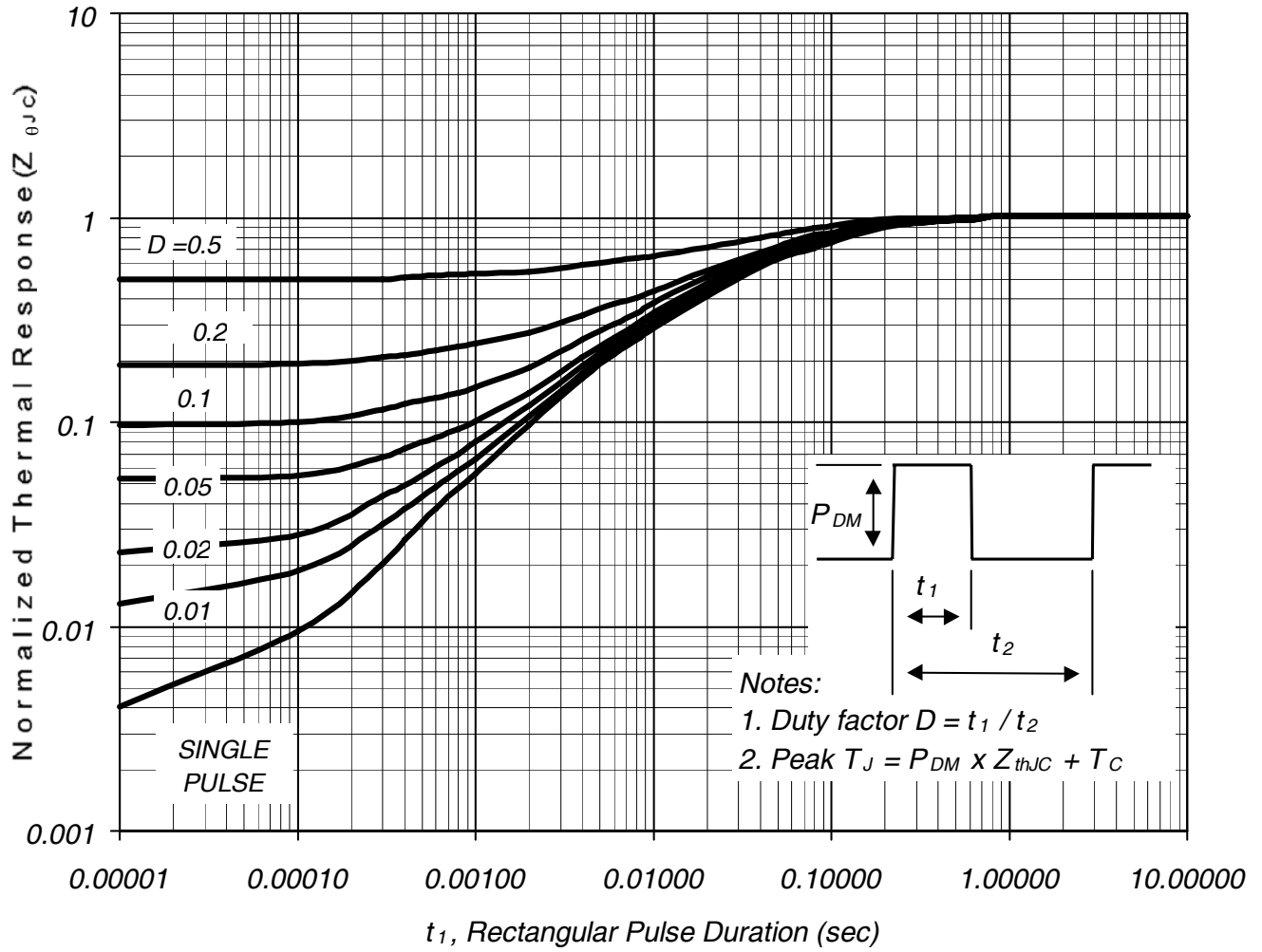


Fig.24 - Normalized Transient Thermal Impedance, Junction-to-Case



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Fig. CT.1 - Gate Charge Circuit (turn-off)

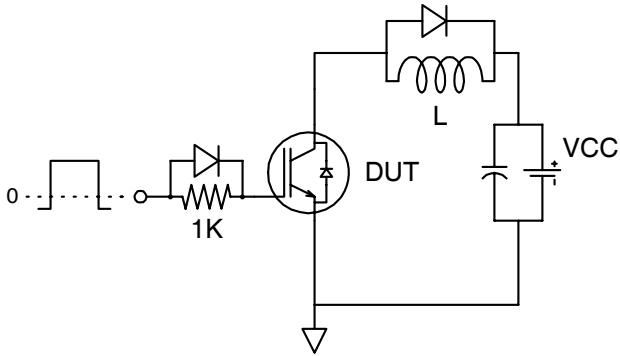


Fig. CT.2 - RBSOA Circuit

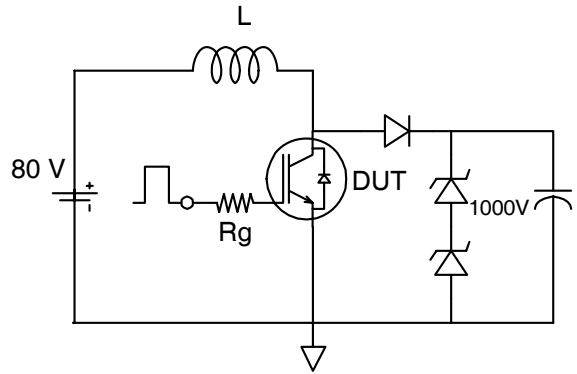


Fig. CT.3 - S.C. SOA Circuit

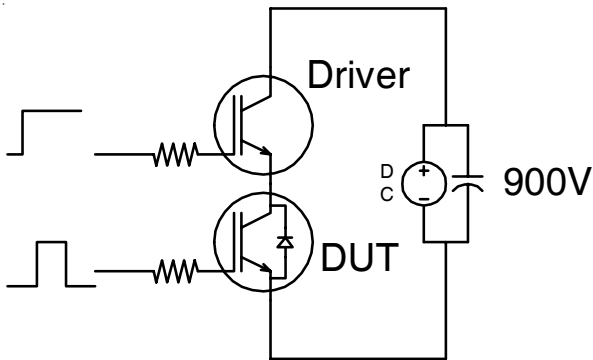


Fig. CT.4 - Switching Loss Circuit

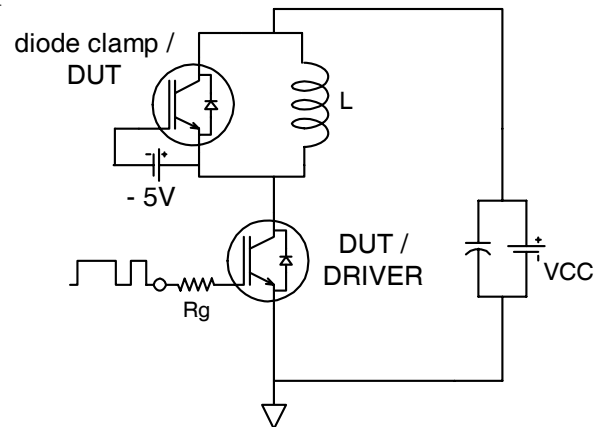
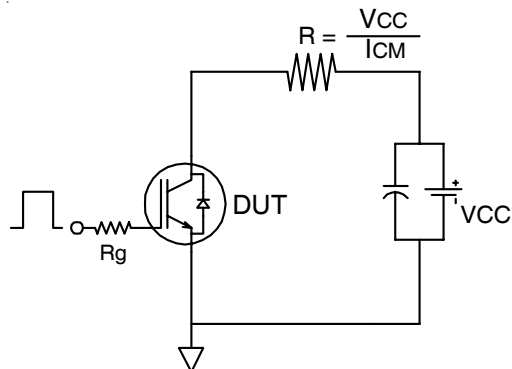


Fig. CT.5 - Resistive Load Circuit



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Fig. WF.1 - Typ. Turn-off Loss Waveform
@ $T_j=125^\circ\text{C}$ using Fig. CT.4

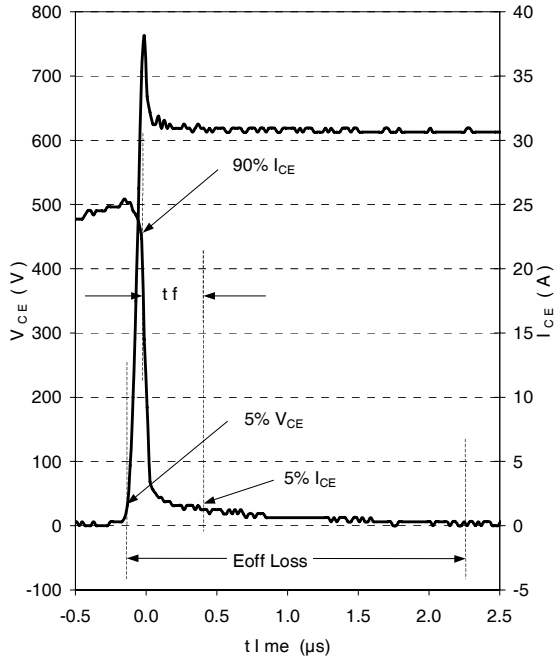


Fig. WF.2 - Typ. Turn-on Loss Waveform
@ $T_j=125^\circ\text{C}$ using Fig. CT.4

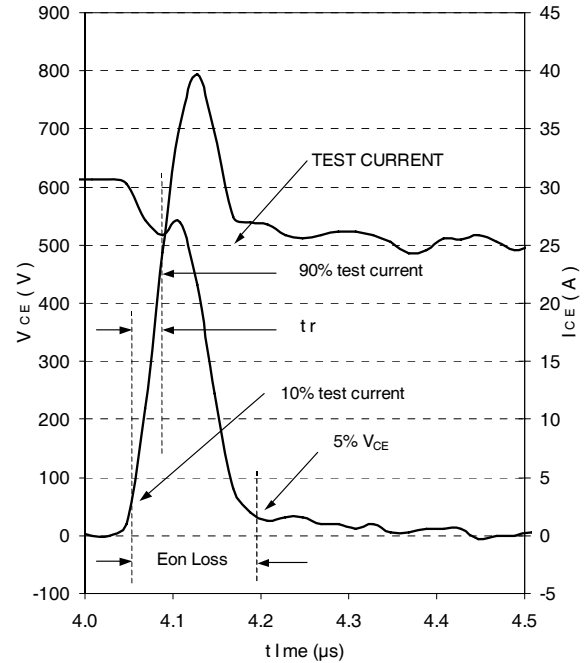


Fig. WF.3 - Typ. Diode Recovery Waveform
@ $T_j=125^\circ\text{C}$ using Fig. CT.4

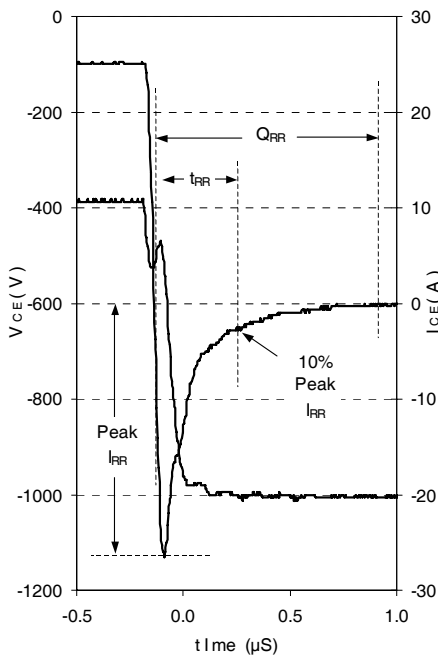
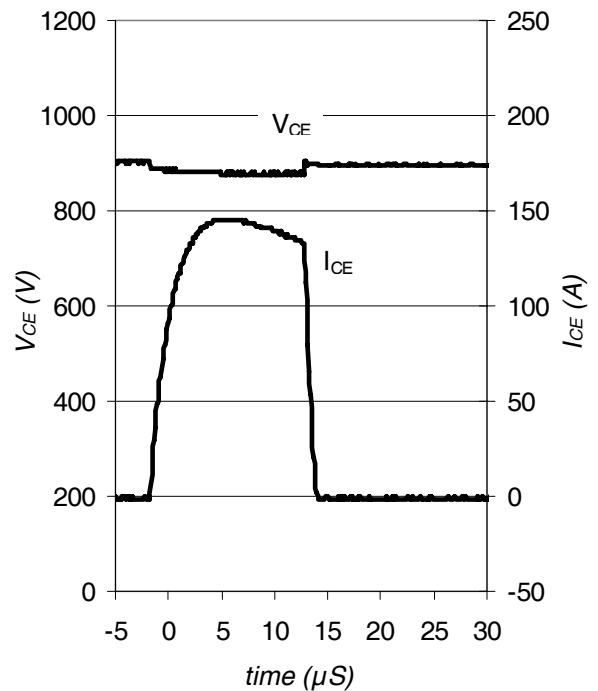
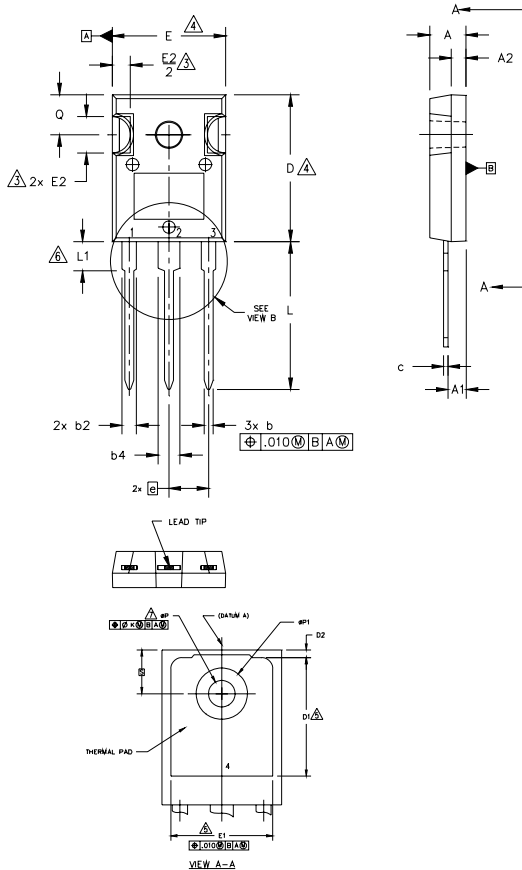


Fig. WF.4 - Typ. S.C. Waveform
@ $T_C=150^\circ\text{C}$ using Fig. CT.3



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TO-247AD Package Outline (Dimensions are shown in millimeters (inches))



- NOTES:
1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.
 2. DIMENSIONS ARE SHOWN IN INCHES.
 3. CONTOUR OF SLOT OPTIONAL.
 4. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
 5. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.
 6. LEAD FINISH UNCONTROLLED IN L1.
 7. ØP TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5 ° TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.
 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AD.

| SYMBOL | INCHES | | MILLIMETERS | | NOTES |
|--------|----------|------|-------------|-------|-------|
| | MIN. | MAX. | MIN. | MAX. | |
| A | .183 | .209 | 4.65 | 5.31 | |
| A1 | .087 | .102 | 2.21 | 2.59 | |
| A2 | .059 | .098 | 1.50 | 2.49 | |
| b | .039 | .055 | 0.99 | 1.40 | |
| b1 | .039 | .053 | 0.99 | 1.35 | |
| b2 | .065 | .094 | 1.65 | 2.39 | |
| b3 | .065 | .092 | 1.65 | 2.34 | |
| b4 | .102 | .135 | 2.59 | 3.43 | |
| b5 | .102 | .133 | 2.59 | 3.38 | |
| c | .015 | .035 | 0.38 | 0.89 | |
| c1 | .015 | .033 | 0.38 | 0.84 | |
| D | .776 | .815 | 19.71 | 20.70 | 4 |
| D1 | .515 | - | 13.08 | - | 5 |
| D2 | .020 | .053 | 0.51 | 1.35 | |
| E | .602 | .625 | 15.29 | 15.87 | 4 |
| E1 | .530 | - | 13.46 | - | |
| E2 | .178 | .216 | 4.52 | 5.49 | |
| e | .215 BSC | | 5.46 BSC | | |
| Øk | .010 | | 0.25 | | |
| L | .780 | .827 | 19.57 | 21.00 | |
| L1 | .146 | .169 | 3.71 | 4.29 | |
| ØP | .140 | .144 | 3.56 | 3.66 | |
| ØF1 | - | .291 | - | 7.39 | |
| Q | .209 | .224 | 5.31 | 5.69 | |
| S | .217 BSC | | 5.51 BSC | | |

LEAD ASSIGNMENTS

- HEXFET**
- 1.- GATE
 - 2.- DRAIN
 - 3.- SOURCE
 - 4.- DRAIN

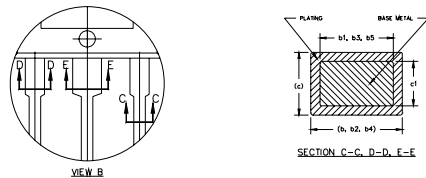
IGBTs, CoPACK

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER
- 4.- COLLECTOR

DIODES

- 1.- ANODE/OPEN
- 2.- CATHODE
- 3.- ANODE

9. For the most current drawing please refer to IR website at <http://www.irf.com/package/pkigtb.html>

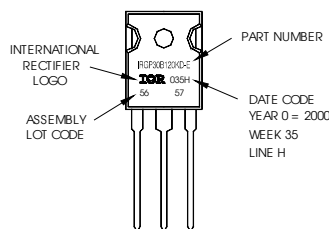


TO-247AC package is not recommended for Surface Mount Application.

TO-247AD Part Marking Information

EXAMPLE: THIS IS AN IRGP30B120KD-E
WITH ASSEMBLY
LOT CODE 5657
ASSEMBLED ON WW 35, 2000
IN THE ASSEMBLY LINE "H"

Note: "P" in assembly line position
indicates "Lead-Free"



International
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Data and specifications subject to change without notice. 9/07